Thanks to rapidly advancing technology, the field of implant dentistry is always changing and evolving. Clinicians must be vigilant in their efforts to keep up with new techniques, new products and new technology that could affect their treatment planning.

And that’s what makes the publication you are holding right now so valuable.

For this issue of *implants*, we’ve assembled a collection of articles from a variety of respected names in dentistry. These expert clinicians are sharing their first-hand knowledge and expertise with you. In this issue, you can read about graftless solutions in implant dentistry, and you can also learn about the reseat implant impression technique.

We also have important information on upcoming implant-focused events, such as the AAIP and the AAID, and about new implant products and technology.

But there’s more.

Every issue of *implants* magazine also contains a C.E. component. By reading the set of articles (beginning on Page 8) on “Graftless Solution in Implant Dentistry: Part One” by Drs. Jivraj and Zarrinkelk and “The reseat implant impression technique” by Dr. Kalman and then taking short online quizzes about these articles at www.DTStudyClub.com, you will gain one ADA CERP-certified C.E. credit per article. Keep in mind that because *implants* is a quarterly magazine, you can actually chisel at least four C.E. credits per year out of your already busy life without any more lost revenue and time away from your practice.

To learn more about how you can take advantage of this C.E. opportunity, visit www.DTStudyClub.com. Annual subscribers to the magazine ($50) need only register at the Dental Tribune Study Club website to access these C.E. materials free of charge. Non-subscribers may take the C.E. quiz after registering on the DT Study Club website and paying a nominal fee.

I know that taking time away from your practice to pursue C.E. credits is costly in terms of lost revenue and time, and that is another reason *implants* is such a valuable publication.

I hope you enjoy this issue and that you get the most out of it.

Sincerely,

Torsten Oemus
Publisher